Notice of References Cited Application/Control No. 10/612,766 Examiner Luan K. Bui Applicant(s)/Patent Under Reexamination YEWDALL ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,997,677	12-1976	Hirsch et al.	206/484
*	В	US-5,293,997	03-1994	Hustad et al.	220/788
*	С	US-6,364,152	04-2002	Poslinski et al.	220/788
*	. D	US-3,679,088	07-1972	Swett et al.	220/789
*	E	US-6,189,717	02-2001	Versaw et al.	220/795
*	F	US-5,984,137	11-1999	Grosjean, Maurice	220/795
*	G	US-5,340,741	08-1994	Lemonnier, Jean	220/203.09
*	Н	US-5,348,549	09-1994	Brown et al.	220/788
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	, US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	· Q	·				
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	٦						
	>						
	>	·					
	X						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.